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March 2013

FQPF47P06 / FQPF47P06YDTU

P-Channel QFET® MOSFET

-60 V, -30 A, 26 m Ω

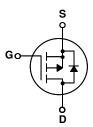
Description

This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor[®]'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- -30 A, -60 V, $R_{DS(on)}$ =26 m $\Omega(Max.)$ @ V_{GS} =-10 V, I_D =-15 A
- Low Gate Charge (Typ. 84 nC)
- Low Crss (Typ. 320 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQPF47P06 / FQPF47P06YDTU	Unit
V_{DSS}	Drain-Source Voltage		-60	V
I _D	Drain Current - Continuous (T _C = 25°	°C)	-30	Α
	- Continuous (T _C = 100	O°C)	-21.2	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	-120	Α
V _{GSS}	Gate-Source Voltage		± 25	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	820	mJ
I _{AR}	Avalanche Current	(Note 1)	-30	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	6.2	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-7.0	V/ns
P _D	Power Dissipation (T _C = 25°C)		62	W
	- Derate above 25°C		0.41	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C
'L			300	

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.42	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W	

	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-60			V
ΔBV_{DSS}	Breakdown Voltage Temperature Coefficient	I _D = -250 μA, Referenced to 25°C		-0.06		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -60 V, V _{GS} = 0 V			-1	μΑ
		V _{DS} = -48 V, T _C = 150°C			-10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -25 V, V _{DS} = 0 V			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 25 V, V _{DS} = 0 V			100	nA
O:: Ob :			I		l	
V _{GS(th)}	aracteristics Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-2.0		-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -15 \text{ A}$		0.021	0.026	Ω
9 _{FS}	Forward Transconductance	V _{DS} = -30 V, I _D = -15 A (Note 4)		19		S
C _{oss} C _{rss}	Output Capacitance Reverse Transfer Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		1300 320	1700 420	pF pF
C _{rss}	Reverse Transfer Capacitance			320	420	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -30 \text{ V}, I_{D} = -23.5 \text{ A},$		50	110	ns
	Turn-On Rise Time	$R_G = 25 \Omega$		450	910	ns
t _r		7 4 -		100	210	ns
	Turn-Off Delay Time					
t _{d(off)}	Turn-Off Delay Time Turn-Off Fall Time	(Note 4, 5)		195	400	
t _{d(off)} t _f Q _g		(Note 4, 5) V _{DS} = -48 V, I _D = -47 A,		195 84		ns
t _{d(off)} t _f Q _g	Turn-Off Fall Time	, , ,			400	ns nC
t _{d(off)} t _f Q _g Q _{gs}	Turn-Off Fall Time Total Gate Charge	V _{DS} = -48 V, I _D = -47 A,		84	400	ns nC nC
td(off) tf Qg Qgs Qgd	Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DS} = -48 \text{ V}, I_{D} = -47 \text{ A},$ $V_{GS} = -10 \text{ V}$ (Note 4, 5)		84 18	400 110 	ns nC nC
t _d (off) t _f Q _g Q _{gs} Q _{gd}	Turn-Off Fall Time Total Gate Charge Gate-Source Charge	V_{DS} = -48 V, I_{D} = -47 A, V_{GS} = -10 V (Note 4, 5)		84 18	400 110 	ns nC nC
$t_{d(off)}$ t_{f} Q_{g} Q_{gs} Q_{gd} Drain-S	Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics and	V _{DS} = -48 V, I _D = -47 A, V _{GS} = -10 V (Note 4, 5) nd Maximum Ratings ode Forward Current		84 18 44	400 110 	ns nC nC
td(off) tf Qg Qgs Qgd Drain-S	Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics at Maximum Continuous Drain-Source Diode Maximum Pulsed Drain-Source Diode F	V _{DS} = -48 V, I _D = -47 A, V _{GS} = -10 V (Note 4, 5) and Maximum Ratings de Forward Current Forward Current		84 18 44	400 110 	ns nC nC
$egin{array}{l} t_r \ t_{d(off)} \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics at Maximum Continuous Drain-Source Dio	V _{DS} = -48 V, I _D = -47 A, V _{GS} = -10 V (Note 4, 5) nd Maximum Ratings ode Forward Current	 	84 18 44	400 110 -30 -120	ns nC nC nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 1.06mH, I_{AS} = -30A, V_{DD} = -25V, R_G = 25 Ω . Starting T_J = 25°C 3. I_{SD} \leq -47A, di/dt \leq 300A/μs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300μs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

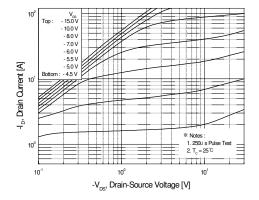


Figure 1. On-Region Characteristics

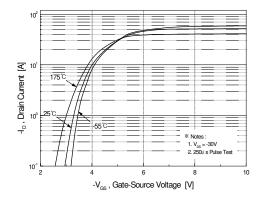


Figure 2. Transfer Characteristics

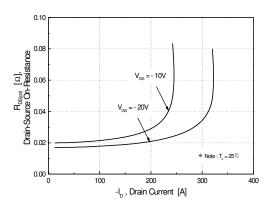


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

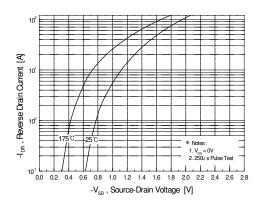


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

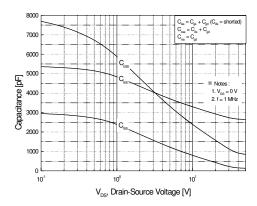


Figure 5. Capacitance Characteristics

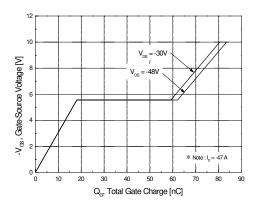
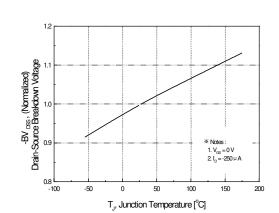


Figure 6. Gate Charge Characteristics



Typical Characteristics (Continued)

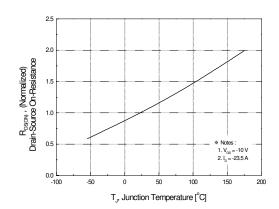
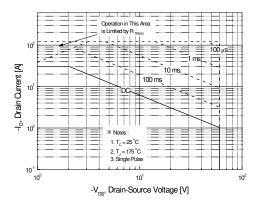


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



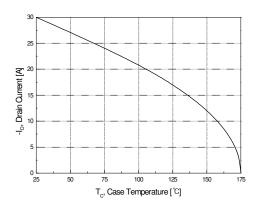


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

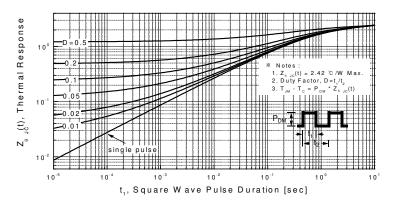
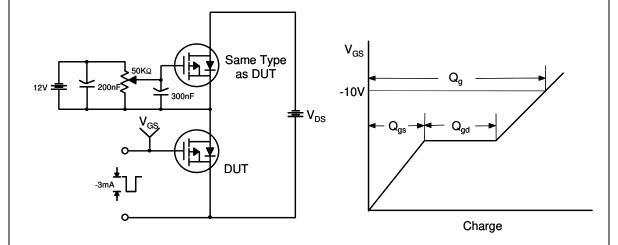
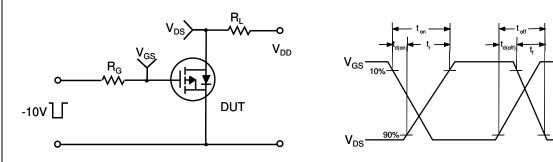


Figure 11. Transient Thermal Response Curve

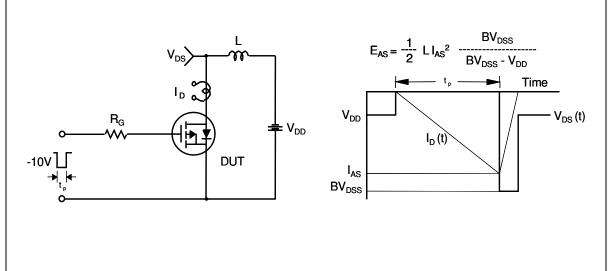
Gate Charge Test Circuit & Waveform



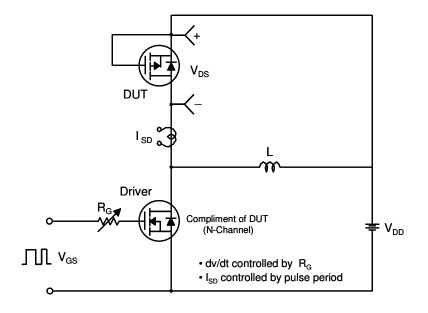
Resistive Switching Test Circuit & Waveforms

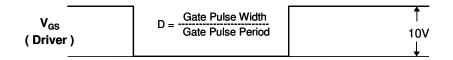


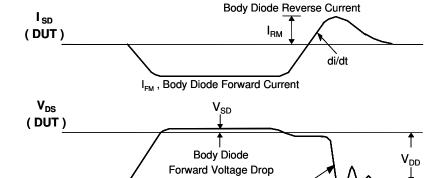
Unclamped Inductive Switching Test Circuit & Waveforms



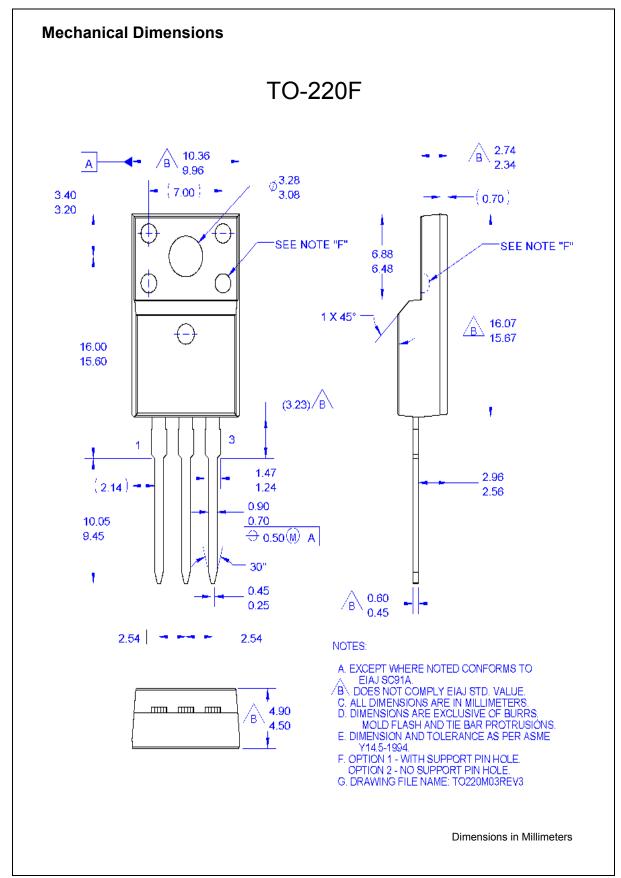
Peak Diode Recovery dv/dt Test Circuit & Waveforms

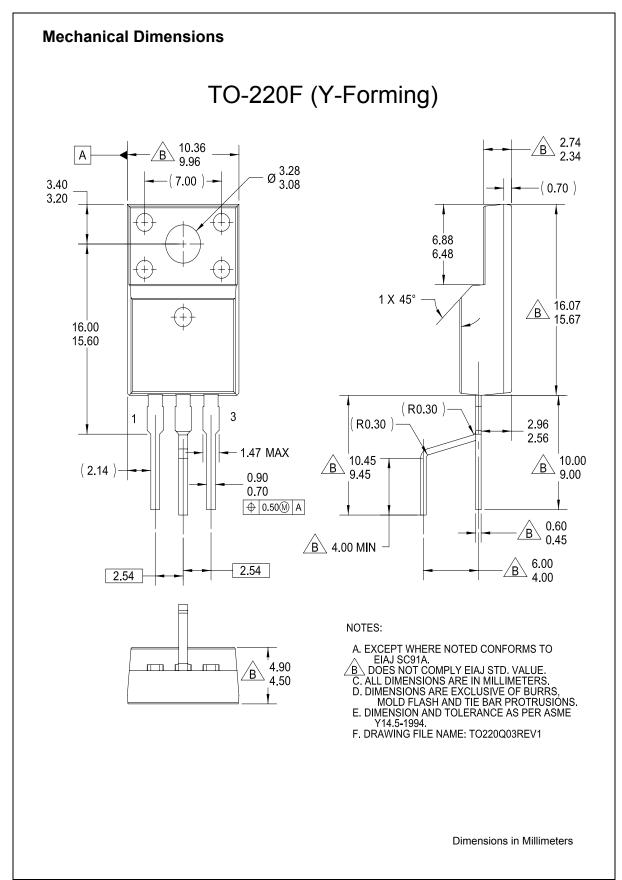






Body Diode Recovery dv/dt









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